Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/550,785	HABEL ET AL.
Examiner	Art Unit
Angel R. Estrada	2831

	SEARCHED					
Class	Subclass	Date	Examiner			
174	650,656, 659,660, 663,668, 152G	8/29/2006	AE			
174	153G, 142	8/29/2006	AE			
174	152R, 153R	8/29/2006	AE			
174	151, 362	8/29/2006	AE			
174	657, 72A	8/29/2006	AE			
16	2.1, 2.2	8/29/2006	AE			
248	56, 68.1	8/29/2006	AE			
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TAI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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